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March 2013

# FDB8443

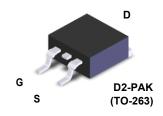
# N-Channel PowerTrench<sup>®</sup> MOSFET 40 V, 182 A, 3.0 m $\Omega$

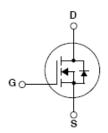
### **Features**

- $\blacksquare$  R<sub>DS(on)</sub> = 2.3 m $\Omega$  ( Typ.)@ V<sub>GS</sub> = 10 V, I<sub>D</sub> = 80 A
- $\blacksquare$  Q<sub>G(tot)</sub> = 142 nC (Typ.)
- Low Miller Charge, Q<sub>GD</sub> = 32 nC( Typ.)
- UIS Capability (Single Pulse and Repetitive Pulse)
- RoHS Compliant

# **Applications**

- Power Tools
- Motor drives and Uninterruptible Power Supplies
- Synchronous Rectification
- Battery Protection Circuit





# **MOSFET Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol		Parameter	FDB8443	Unit
$V_{DSS}$	Drain to Source Voltage		40	V
$V_{GS}$	Gate to Source Voltage		±20	V
		- Continuous (T <sub>C</sub> = 25°C, Silicon Limited)	182*	
	Drain Current	- Continuous (T <sub>C</sub> = 100°C, Silicon Limited)	129*	
ID		- Continuous (T <sub>C</sub> = 25°C, Package Limited)	120	Α
		- Continuous ( $T_A = 25^{\circ}C$ , $R_{\theta JA} = 43^{\circ}C/W$ )	25	
I <sub>DM</sub>	Drain Current	- Pulsed	See Figure 4	
E <sub>AS</sub>	Single Pulse Avalanche E	nergy (Note 1)	531	mJ
ב	Power Dissipation		188	W
$P_{D}$	Derate above 25°C		1.25	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Te	emperature	-55 to +175	°C

<sup>\*</sup>Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

#### **Thermal Characteristics**

Symbol	Parameter	FDB8443	Unit
$R_{\theta JC}$	Thermal Resistance Junction to Case, Max.	0.8	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient, Max. (Note 2)	62	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient TO-263, 1in <sup>2</sup> copper pad area, Max.	43	°C/W

Unit

Max

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Tape Width	Quantity
FDB8443	FDB8443	TO-263AB	330mm	24mm	800 units

**Test Conditions** 

Min

Тур

# Electrical Characteristics T<sub>C</sub> = 25°C unless otherwise noted

Parameter

On Characteristics							
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250μA, V <sub>GS</sub> =	= 0V	40	-	-	V
I <sub>DSS</sub> Zero G	Zana Cata Valtana Dusin Comment	V <sub>DS</sub> = 32V,		-	-	1	
	Zero Gate Voltage Drain Current	$V_{GS} = 0V$	$T_{\rm C} = 150^{\rm o}{\rm C}$	-	-	250	μА
$I_{GSS}$	Gate to Source Leakage Current	V <sub>GS</sub> = ±20V		-	-	±100	nA

#### On Characteristics

Symbol

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2	2.8	4	V
		$I_D = 80A, V_{GS} = 10V$	-	2.3	3.0	
r <sub>DS(on)</sub>	Drain to Source On Resistance	$I_D = 80A$ , $V_{GS} = 10V$ , $T_J = 175$ °C	-	4.2	5.5	mΩ

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V		-	9310	-	pF
C <sub>oss</sub>	Output Capacitance	→V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0 → f = 1MHz	JV,	-	800	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	- 1 - 11VII 12	I = IMMZ		510	-	pF
$R_G$	Gate Resistance	$V_{GS} = 0.5V, f = 1M$	Hz	-	0.9	-	Ω
$Q_{g(TOT)}$	Total Gate Charge at 10V	V <sub>GS</sub> = 0 to 10V		-	142	185	nC
$Q_{g(TH)}$	Threshold Gate Charge	V <sub>GS</sub> = 0 to 2V	V <sub>DD</sub> = 20V	-	17.5	23	nC
Q <sub>gs</sub>	Gate to Source Gate Charge		I <sub>D</sub> = 35A	-	36	-	nC
Q <sub>gs2</sub>	Gate Charge Threshold to Plateau		I <sub>g</sub> = 1mA	-	18.8	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge			-	32	-	nC

# **Switching Characteristics** (V<sub>GS</sub> = 10V)

t <sub>on</sub>	Turn-On Time		-	-	58	ns
t <sub>d(on)</sub>	Turn-On Delay Time	V 00V L 05A	-	18.4	-	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 20V, I_{D} = 35A$ $V_{GS} = 10V, R_{GS} = 2\Omega$	-	17.9	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10V, K <sub>GS</sub> = 212	-	55	-	ns
t <sub>f</sub>	Fall Time		-	13.5	-	ns
t <sub>off</sub>	Turn-Off Time		-	-	109	ns

### **Drain-Source Diode Characteristics**

	V <sub>SD</sub> Sour	Source to Drain Dioge Voltage	I <sub>SD</sub> = 35A	-	0.8	1.25	\/
			I <sub>SD</sub> = 15A	-	0.8	1.0	, v
	t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> = 35A, dI <sub>SD</sub> /dt = 100A/μs	-	42	55	ns
	$Q_{rr}$	Reverse Recovery Charge	isp = 33A, disp/dt = 100A/μs	ı	48	62	nC

- **1:** Starting  $T_J = 25^{\circ}C$ , L = 0.26mH,  $I_{AS} = 64$ A. **2:** Pulse width = 100s.

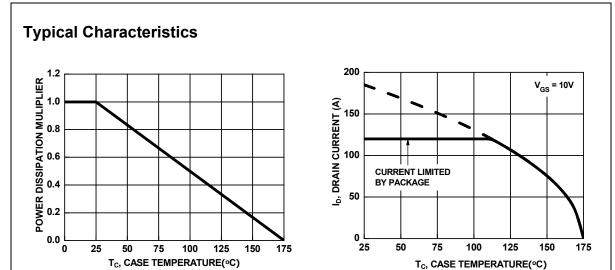


Figure 1. Normalized Power Dissipation vs Case Temperature

Figure 2. Maximum Continuous Drain Current vs Case Temperature

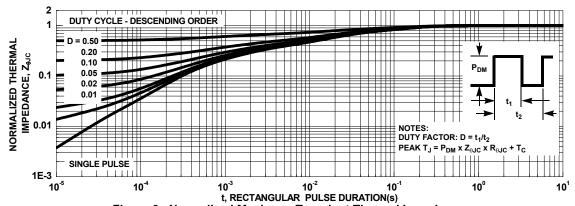


Figure 3. Normalized Maximum Transient Thermal Impedance

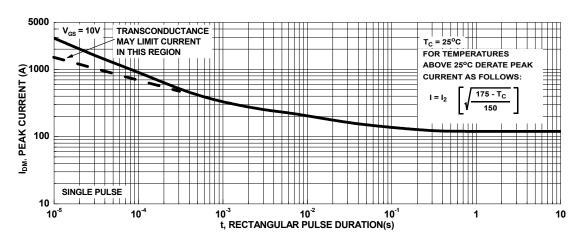
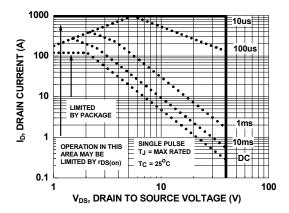
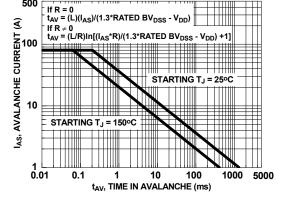


Figure 4. Peak Current Capability

# **Typical Characteristics**



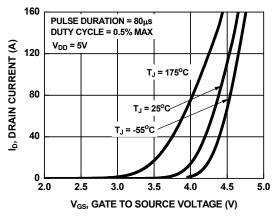
NOTE: Refer to Fairchild Application Notes AN7514 and AN7515



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Figure 5. Forward Bias Safe Operating Area

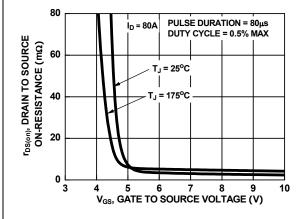




200 PULSE DURATION = 80µs DUTY CYCLE = 0.5% MAX € 160 ID, DRAIN CURRENT V<sub>GS</sub> = 5V  $V_{GS} = 4.5V$ 120 80 40  $V_{GS} = 4V$ 0 V<sub>DS</sub>, DRAIN TO SOURCE VOLTAGE (V)

Figure 7. Transfer Characteristics

Figure 8. Saturation Characteristics



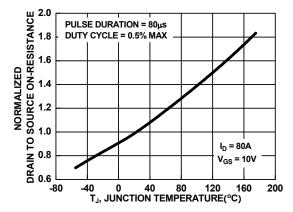


Figure 9. Drain to Source On-Resistance Variation vs Gate to Source Voltage

Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature

# **Typical Characteristics**

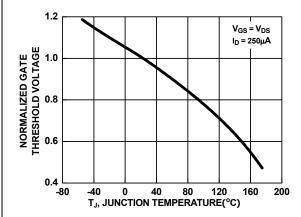


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

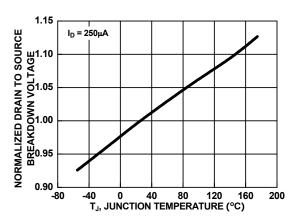


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

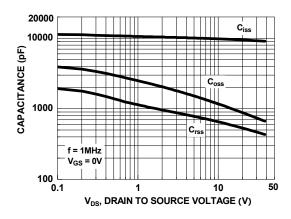


Figure 13. Capacitance vs Drain to Source Voltage

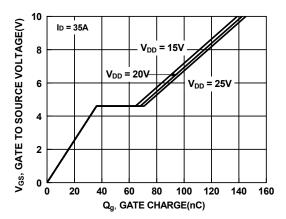


Figure 14. Gate Charge vs Gate to Source Voltage





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